

# DS1270Y/AB 16M Nonvolatile SRAM

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# **FEATURES**

- 5 years minimum data retention in the absence of external power
- Data is automatically protected during power loss
- Unlimited write cycles
- Low-power CMOS operation
- Read and write access times as fast as 70 ns
- Lithium energy source is electrically disconnected to retain freshness until power is applied for the first time
- Full  $\pm 10\%$  V<sub>CC</sub> operating range (DS1270Y)
- Optional ±5% V<sub>CC</sub> operating range (DS1270AB)
- Optional industrial temperature range of -40°C to +85°C, designated IND

#### PIN ASSIGNMENT

NC	1	36	$V_{CC}$
A20	2	35	A19
A18	3	34	NC
A16	4	33	A15
A14	<b>5</b>	32	A17
A12	6	31	WE
A7	7	30	A13
A6	8	29	A8
A5	9	28	A9
A4	10	27	<u>A1</u> 1
A3	11	26	ŌE
A2	12	25	A10
A1	<b>1</b> 3	24	CE
A0	<b>1</b> 4	23	DQ7
DQ0	<b>1</b> 5	22	DQ6
DQ1	16	21	DQ5
DQ2	<b>1</b> 7	20	DQ4
GND	18	19	DQ3

36-Pin ENCAPSULATED PACKAGE 740-mil EXTENDED

# **PIN DESCRIPTION**

A0 - A20- Address Inputs - Data In/Data Out DQ0 - DQ7 CE - Chip Enable WE - Write Enable **OE** - Output Enable  $V_{CC}$ - Power (+5V) - Ground **GND** NC - No Connect

# DESCRIPTION

The DS1270 16M Nonvolatile SRAMs are 16,777,216-bit, fully static nonvolatile SRAMs organized as 2,097,152 words by 8 bits. Each NV SRAM has a self-contained lithium energy source and control circuitry which constantly monitors  $V_{\rm CC}$  for an out-of-tolerance condition. When such a condition occurs, the lithium energy source is automatically switched on and write protection is unconditionally enabled to prevent data corruption. There is no limit on the number of write cycles which can be executed and no additional support circuitry is required for microprocessor interfacing.

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# **READ MODE**

The DS1270 devices execute a read cycle whenever  $\overline{\text{WE}}$  (Write Enable) is inactive (high) and  $\overline{\text{CE}}$  (Chip Enable) and  $\overline{\text{OE}}$  (Output Enable) are active (low). The unique address specified by the 21 address inputs (A<sub>0</sub> - A<sub>20</sub>) defines which of the 2,097,152 bytes of data is accessed. Valid data will be available to the eight data output drivers within  $t_{ACC}$  (Access Time) after the last address input signal is stable, providing that  $\overline{\text{CE}}$  and  $\overline{\text{OE}}$  (Output Enable) access times are also satisfied. If  $\overline{\text{OE}}$  and  $\overline{\text{CE}}$  access times are not satisfied, then data access must be measured from the later-occurring signal ( $\overline{\text{CE}}$  or  $\overline{\text{OE}}$ ) and the limiting parameter is either  $t_{CO}$  for  $\overline{\text{CE}}$  or  $t_{OE}$  for  $\overline{\text{OE}}$  rather than  $t_{ACC}$ .

# WRITE MODE

The DS1270 devices execute a write cycle whenever  $\overline{WE}$  and  $\overline{CE}$  signals are active (low) after address inputs are stable. The later-occurring falling edge of  $\overline{CE}$  or  $\overline{WE}$  will determine the start of the write cycle. The write cycle is terminated by the earlier rising edge of  $\overline{CE}$  or  $\overline{WE}$ . All address inputs must be kept valid throughout the write cycle.  $\overline{WE}$  must return to the high state for a minimum recovery time ( $t_{WR}$ ) before another cycle can be initiated. The  $\overline{OE}$  control signal should be kept inactive (high) during write cycles to avoid bus contention. However, if the output drivers are enabled ( $\overline{CE}$  and  $\overline{OE}$  active) then  $\overline{WE}$  will disable the outputs in  $t_{ODW}$  from its falling edge.

# DATA RETENTION MODE

The DS1270AB provides full-functional capability for  $V_{CC}$  greater than 4.75 volts and write protects by 4.5 volts. The DS1270Y provides full-functional capability for  $V_{CC}$  greater than 4.5 volts and write protects by 4.25 volts. Data is maintained in the absence of  $V_{CC}$  without any additional support circuitry. The nonvolatile static RAMs constantly monitor  $V_{CC}$ . Should the supply voltage decay, the NV SRAMs automatically write protect themselves, all inputs become don't care, and all outputs become high-impedance. As  $V_{CC}$  falls below approximately 3.0 volts, a power switching circuit connects the lithium energy source to RAM to retain data. During power-up, when  $V_{CC}$  rises above approximately 3.0 volts, the power switching circuit connects external  $V_{CC}$  to RAM and disconnects the lithium energy source. Normal RAM operation can resume after  $V_{CC}$  exceeds 4.75 volts for the DS1270AB and 4.5 volts for the DS1270Y.

# FRESHNESS SEAL

Each DS1270 device is shipped from Dallas Semiconductor with its lithium energy source disconnected, guaranteeing full energy capacity. When  $V_{CC}$  is first applied at a level greater than  $V_{TP}$ , the lithium energy source is enabled for battery backup operation.

# **ABSOLUTE MAXIMUM RATINGS\***

Voltage on Any Pin Relative to Ground -0.3V to +6.0V

Operating Temperature 0°C to 70°C; -40°C to +85°C for IND parts Storage Temperature -40°C to +70°C; -40°C to +85°C for IND parts

Soldering Temperature +260°C for 10 seconds

Caution: Do Not Reflow (Wave or Hand Solder Only)

# RECOMMENDED DC OPERATING CONDITIONS

(t<sub>A</sub>: See Note 10)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
DS1270AB Power Supply Voltage	$V_{CC}$	4.75	5.0	5.25	V	
DS1270Y Power Supply Voltage	$V_{CC}$	4.5	5.0	5.5	V	
Logic 1 Input Voltage	$V_{\mathrm{IH}}$	2.2		$V_{CC}$	V	
Logic 0 Input Voltage	$V_{ m IL}$	0		+0.8	V	

# DC ELECTRICAL CHARACTERISTICS

 $(V_{CC}=5V \pm 5\% \text{ for DS1270AB})$ 

CHARACTERISTICS (t<sub>A</sub>: See Note 10) ( $V_{CC}$ =5V ± 10% for DS1270Y)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Leakage Current	$I_{\mathrm{IL}}$	-4.0		+4.0	μΑ	
I/O Leakage Current	$I_{IO}$	-4.0		+4.0	μΑ	
Output Current @ 2.4V	$I_{OH}$	-1.0			mA	
Output Current @ 0.4V	$I_{OL}$	2.0			mA	
Standby Current $\overline{\text{CE}} = 2.2 \text{V}$	I <sub>CCS1</sub>		1.0	1.5	mA	
Standby Current $\overline{CE} = V_{CC} - 0.5V$	$I_{CCS2}$		100	250	μΑ	
Operating Current	I <sub>CCO1</sub>			85	mA	
Write Protection Voltage (DS1270AB)	$V_{TP}$	4.50	4.62	4.75	V	
Write Protection Voltage (DS1270Y)	$V_{TP}$	4.25	4.37	4.5	V	

**CAPACITANCE**  $(t_A=25^{\circ}C)$ 

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Capacitance	$C_{IN}$		20	40	pF	
Output Capacitance	$C_{I/O}$		20	40	pF	

<sup>\*</sup> This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

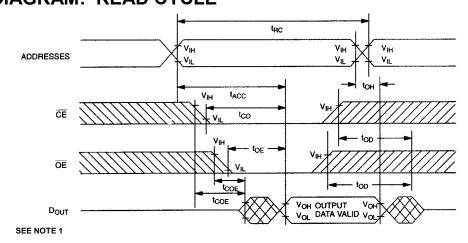
# AC ELECTRICAL CHARACTERISTICS

( $V_{CC}$ =5 $V \pm 5\%$  for DS1270AB)

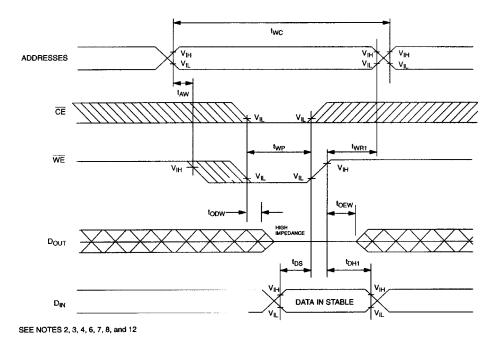
 $(t_A: See Note 10) (V_{CC}=5V \pm 10\% for DS1270Y)$ 

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		DS1270AB-70 DS1270Y-70		DS1270AB-100 DS1270Y-100			
PARAMETER	SYMBOL	MIN	MAX	MIN	MAX	UNITS	NOTES
Read Cycle Time	$t_{RC}$	70		100		ns	
Access Time	$t_{ACC}$		70		100	ns	
OE to Output Valid	$t_{OE}$		35		50	ns	
CE to Output Valid	$t_{CO}$		70		100	ns	
OE or CE to Output Active	t <sub>COE</sub>	5		5		ns	5
Output High Z from Deselection	$t_{\mathrm{OD}}$		25		35	ns	5
Output Hold from Address Change	t <sub>OH</sub>	5		5		ns	
Write Cycle Time	$t_{ m WC}$	70		100		ns	
Write Pulse Width	$t_{\mathrm{WP}}$	55		75		ns	3
Address Setup Time	$t_{AW}$	0		0		ns	
Write Recovery Time	$t_{\mathrm{WR1}}$ $t_{\mathrm{WR2}}$	5 15		5 15		ns ns	12 13
Output High Z from WE	$t_{\mathrm{ODW}}$		25		35	ns	5
Output Active from WE	$t_{ m OEW}$	5		5		ns	5
Data Setup Time	$t_{\rm DS}$	30		40		ns	4
Data Hold Time	t <sub>DH1</sub> t <sub>DH2</sub>	0 10		0 10		ns ns	12 13

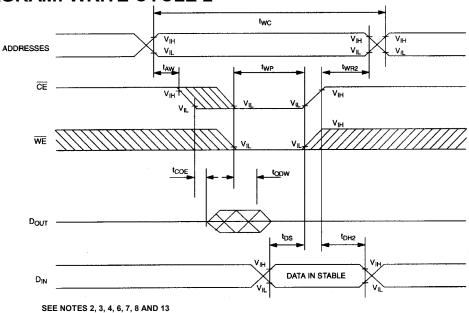
# TIMING DIAGRAM: READ CYCLE



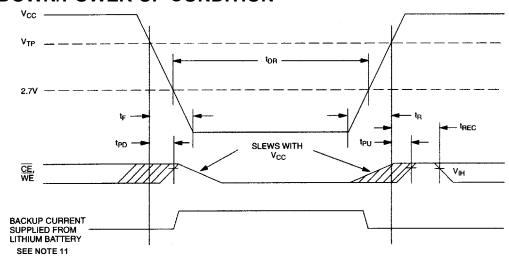
# **TIMING DIAGRAM: WRITE CYCLE 1**



# **TIMING DIAGRAM: WRITE CYCLE 2**



# POWER-DOWN/POWER-UP CONDITION



# POWER-DOWN/POWER-UP TIMING

(t<sub>A</sub>: See Note 10)

					<i>,</i> ,	
PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
$V_{CC}$ Fail Detect to $\overline{CE}$ and $\overline{WE}$ Inactive	$t_{\mathrm{PD}}$			1.5	μs	11
V <sub>CC</sub> slew from V <sub>TP</sub> to 0V	$t_{\mathrm{F}}$	150			μs	
V <sub>CC</sub> slew from 0V to V <sub>TP</sub>	$t_R$	150			μs	
$V_{CC}$ Valid to $\overline{CE}$ and $\overline{WE}$ Inactive	$t_{ m PU}$			2	ms	
V <sub>CC</sub> Valid to End of Write Protection	$t_{REC}$			125	ms	

 $(t_A=25^{\circ}C)$ 

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Expected Data Retention Time	$t_{DR}$	5			years	9

# **WARNING:**

Under no circumstance are negative undershoots, of any amplitude, allowed when device is in battery backup mode.

#### NOTES:

- 1.  $\overline{\text{WE}}$  is high for a read cycle.
- 2.  $\overline{OE} = V_{IH}$  or  $V_{IL}$ . If  $\overline{OE} = V_{IH}$  during write cycle, the output buffers remain in a high-impedance state.
- 3.  $t_{WP}$  is specified as the logical AND of  $\overline{CE}$  and  $\overline{WE}$ .  $t_{WP}$  is measured from the latter of  $\overline{CE}$  or  $\overline{WE}$  going low to the earlier of  $\overline{CE}$  or  $\overline{WE}$  going high.
- 4.  $t_{DS}$  is measured from the earlier of  $\overline{CE}$  or  $\overline{WE}$  going high.
- 5. These parameters are sampled with a 5 pF load and are not 100% tested.
- 6. If the  $\overline{\text{CE}}$  low transition occurs simultaneously with or latter than the  $\overline{\text{WE}}$  low transition, the output buffers remain in a high-impedance state during this period.
- 7. If the  $\overline{\text{CE}}$  high transition occurs prior to or simultaneously with the  $\overline{\text{WE}}$  high transition, the output buffers remain in high-impedance state during this period.

- 8. If  $\overline{\text{WE}}$  is low or the  $\overline{\text{WE}}$  low transition occurs prior to or simultaneously with the  $\overline{\text{CE}}$  low transition, the output buffers remain in a high-impedance state during this period.
- 9. Each DS1270 has a built-in switch that disconnects the lithium source until the user first applies V<sub>CC</sub>. The expected t<sub>DR</sub> is defined as accumulative time in the absence of V<sub>CC</sub> starting from the time power is first applied by the user. This parameter is assured by component selection, process control, and design. It is not measured directly during production testing.
- 10. All AC and DC electrical characteristics are valid over the full operating temperature range. For commercial products, this range is 0°C to 70°C. For industrial products (IND), this range is -40°C to +85°C.
- 11. In a power-down condition the voltage on any pin may not exceed the voltage on V<sub>CC</sub>.
- 12.  $t_{WR1}$  and  $t_{DH1}$  are measured from  $\overline{WE}$  going high.
- 13.  $t_{WR2}$  and  $t_{DH2}$  are measured from  $\overline{CE}$  going high.
- 14. DS1270 modules are recognized by Underwriters Laboratory (U.L.®) under file E99151.

# DC TEST CONDITIONS

Outputs Open Cycle = 200ns for operating current All voltages are referenced to ground

# **AC TEST CONDITIONS**

Output Load: 100 pF + 1TTL Gate Input Pulse Levels: 0.0 to 3.0 volts Timing Measurement Reference Levels

> Input: 1.5V Output: 1.5V

Input pulse Rise and Fall Times: 5 ns

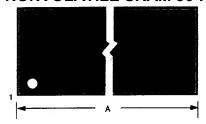
# ORDERING INFORMATION

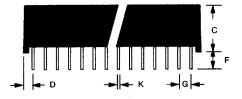
Part Number	Temperature Range	Supply Tolerance	Pin/Package	Speed Grade
DS1270AB-70	0°C to +70°C	5V ± 5%	36 / 740 EMOD	70ns
DS1270AB-70#	0°C to +70°C	5V ± 5%	36 / 740 EMOD	70ns
DS1270AB-70IND	-40°C to +85°C	$5V \pm 5\%$	36 / 740 EMOD	70ns
DS1270AB-70IND#	-40°C to +85°C	5V ± 5%	36 / 740 EMOD	70ns
DS1270AB-100	0°C to +70°C	5V ± 5%	36 / 740 EMOD	100ns
DS1270AB-100#	0°C to +70°C	5V ± 5%	36 / 740 EMOD	100ns
DS1270Y-70	0°C to +70°C	$5V \pm 10\%$	36 / 740 EMOD	70ns
DS1270Y-70#	0°C to +70°C	5V ± 10%	36 / 740 EMOD	70ns
DS1270Y-70IND	-40°C to +85°C	5V ± 10%	36 / 740 EMOD	70ns
DS1270Y-70IND#	-40°C to +85°C	$5V \pm 10\%$	36 / 740 EMOD	70ns
DS1270Y-100	0°C to +70°C	5V ± 10%	36 / 740 EMOD	100ns
DS1270Y-100#	0°C to +70°C	5V ± 10%	36 / 740 EMOD	100ns

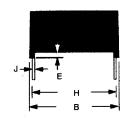
<sup>#</sup> Denotes RoHS-compliant product.

<sup>\*</sup> DS9034PC or DS9034PCI (PowerCap) required. Must be ordered separately.

# DS1270Y/AB NONVOLATILE SRAM 36-PIN 740-MIL EXTENDED MODULE, LONG







PKG	36-PIN					
DIM	MIN	MAX				
A IN.	2.080	2.100				
MM	52.83	53.34				
B IN.	0.720	0.740				
MM	18.29	18.80				
C IN.	0.395 10.03	0.405 10.29				
D IN.	0.180	0.210				
MM	4.57	5.33				
E IN.	0.015	0.025				
MM	0.38	0.63				
F IN.	0.120	0.150				
MM	3.05	4.06				
G IN.	0.090	0.110				
MM	2.29	2.79				
H IN.	0.590	0.630				
MM	14.99	16.00				
J IN.	0.008	0.012				
MM	0.20	0.30				
K IN.	0.015	0.021				
MM	0.38	0.53				